## Notice of References Cited Application/Control No. 10/798,867 Examiner Madeleine AV Nguyen Applicant(s)/Patent Under Reexamination HSU ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,462,835 B1	10-2002	Loushin et al.	358/1.9
*	В	US-6,686,953 B1	02-2004	Holmes, Joseph	348/179
*	С	US-2005/0057473 A1	03-2005	Hsu et al.	345/089
*	D	US-6,963,668 B2	11-2005	Engeldrum et al.	382/233
*	Е	US-2006/0033695 A1	02-2006	Kudo et al.	345/089
*	F	US-2006/0146066 A1	07-2006	Sasaki, Takashi	345/590
*	G	US-7,110,001 B2	09-2006	Sasaki, Takashi	345/590
*	Н	US-2007/0001952 A1	01-2007	Lee, Seung-Woo	345/ <b>59</b> 8
*	ı	US-2007/0036457 A1	02-2007	Saquib et al.	382/274
*	J	US-7,205,970 B2	04-2007	Kim et al.	345/89
*	К	US-2007/0122027 A1	05-2007	Kunita et al.	382/154
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name '	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	T					

## **NON-PATENT DOCUMENTS**

*	Γ	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.